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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/823,466	MILLS ET AL.	
Examiner .	Art Unit	
Cloud K. Lee	3753	

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Class	Subclass	Date	Examiner
251	129.14- 129.22	11/1/2006	CL
137	625.64	11/1/2006	CL
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